

### **General Description**

The WSD65N12GDN56 is SGT II technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

The WSD65N12GDN56 meet the RoHS and Green Product requirement,100% EAS guaranteed with full function reliability approved.

#### Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

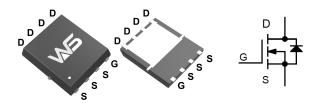
### **Product Summery**

BV <sub>DSS</sub>	R <sub>DSON</sub>	Ι <sub>D</sub>
120V	10mΩ	72A

### Applications

- Mobile phone fast charging.
- Brushless motor
- Home appliance control board

## DFN5X6 Pin Configuration



#### **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage	120	V	
V <sub>GS</sub>	Gate-Source Voltage	±20	V	
I <sub>D</sub> @T <sub>C</sub> =25℃	Continuous Drain Current	72	А	
I <sub>DP</sub>	Pulsed Drain Current	150	A	
EAS	Avalanche Energy, Single pulse	50	mJ	
P <sub>D</sub> @T <sub>C</sub> =25℃	Total Power Dissipation	140	W	
T <sub>STG</sub>	Storage Temperature Range -55 to 150		°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	

#### **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit	
R <sub>θJA</sub>	Thermal Resistance Junction-Ambient <sup>1</sup>		25	°C/W	
R <sub>θJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>		0.89	℃/W	



## Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS}$ =0V , I <sub>D</sub> =250uA	120			V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	VGS=10V,ID=10A.		10	12	mΩ
		VGS=4.5V,ID=10A.		15	23	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS}$ = $V_{DS}$ , $I_D$ =250 $uA$	2.0	3.0	4.5	V
I <sub>DSS</sub>	Drain-Source Leakage Current	$V_{\text{DS}}\text{=}80\text{V}$ , $V_{\text{GS}}\text{=}0\text{V}$ , $T_{\text{J}}\text{=}25^\circ\!\mathrm{C}$			1	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}=\pm20V$ , $V_{DS}$ =0V			±100	nA
$Q_g$	Total Gate Charge (10V)	V <sub>DS</sub> =50V , V <sub>GS</sub> =10V , I <sub>D</sub> =25A		33		nC
Q <sub>gs</sub>	Gate-Source Charge			5.6		
$Q_{gd}$	Gate-Drain Charge			7.2		
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> =50V , V <sub>GS</sub> =10V , R <sub>G</sub> =2Ω, I <sub>D</sub> =25A		22		ns
Tr	Rise Time			10		
$T_{d(off)}$	Turn-Off Delay Time			85		
T <sub>f</sub>	Fall Time			112		
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =50V , V <sub>GS</sub> =0V , f=1MHz		2640		pF
Coss	Output Capacitance			330		
Crss	Reverse Transfer Capacitance			11		
ls	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			50	А
I <sub>SP</sub>	Pulsed Source Current				150	А
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =12A , T <sub>J</sub> =25℃			1.3	V
t <sub>rr</sub>	Reverse Recovery Time	IF=25A,dI/dt=100A/µs,Tյ=25℃		62		nS
Qrr	Reverse Recovery Charge			135		nC

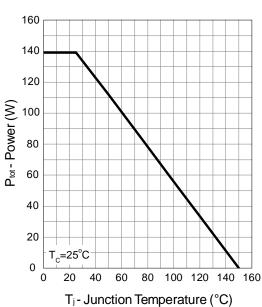
## Note

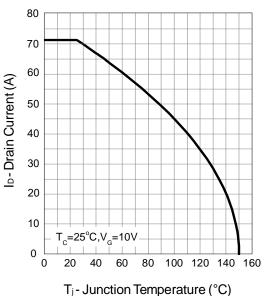
- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) Pd is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_a=25$  °C.
- 5)  $V_{DD}$ =50 V, R<sub>G</sub>=25  $\Omega$ , L=0.3 mH, starting T<sub>j</sub>=25 °C.



# **Typical Operating Characteristics**

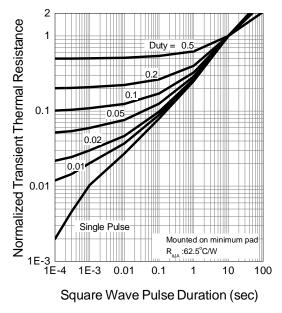
**Power Dissipation** 



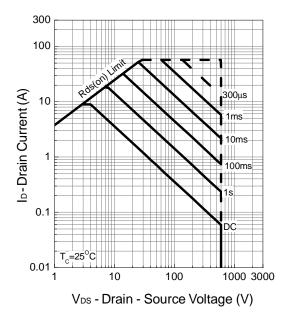


**Drain Current** 

**Thermal Transient Impedance:** 

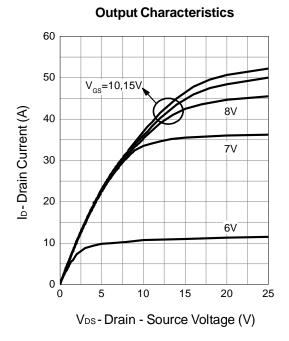


Safe Operation Area



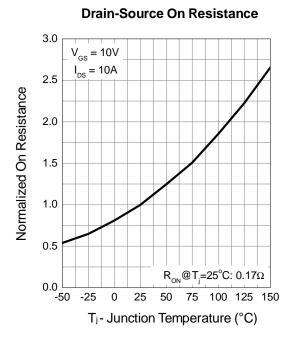


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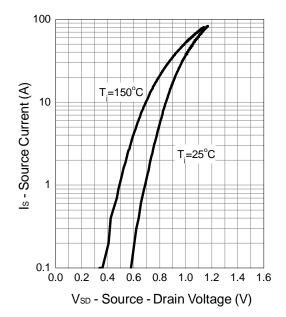


4.0 I<sub>DS</sub>=250μA Normalized Breakdown Voltage 3.5 2.0 1.5 1.0 0.5 0 -50 -25 25 50 75 0 100 125 150 T<sub>j</sub>-Junction Temperature (°C)

V<sub>GS(th)</sub> vs Junction Temperature

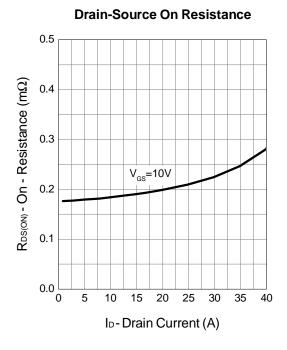


Source-Drain Diode Forward

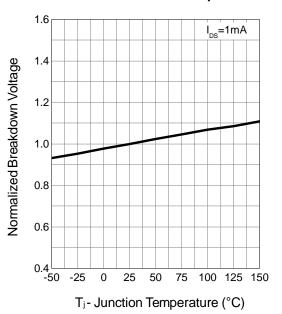


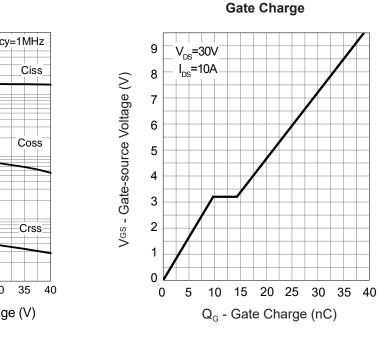


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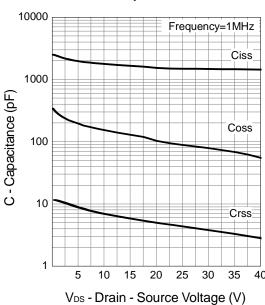


**BVDSS vs Junction Temperature** 





Capacitance





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